

JSM 6335 F



- * Field emission gun
- * SEI detector
 - 15 kV: 1.5 nm (WD 4 mm) resolution
 - 1 kV: 0.5 nm (WD 4 mm) resolution
 - Magnification: 10 to 500.000 X
- * BE detector
 - 30 kV: 2 nm (WD 8 mm) resolution
- * EDS system

